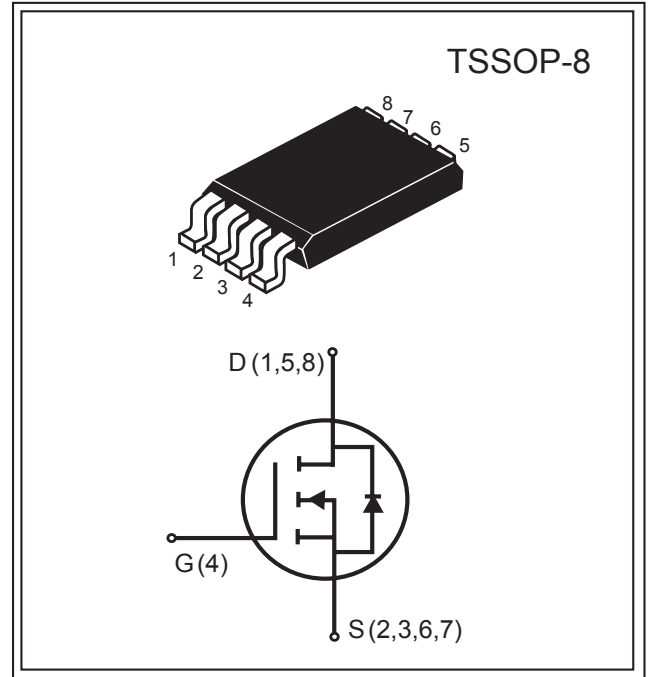




Product Summary		
V _{DS} (V)	I _D (A)	R _{DS(ON)} (mΩ) Max
30V	8A	23 @V _{GS} = 10V
		43 @V _{GS} = 4.5V



FEATURES

- ◆ Super high density cell design for low R_{DS(ON)}.
- ◆ Rugged and reliable.
- ◆ TSSOP-8 package.
- ◆ Pb free.

ABSOLUTE MAXIMUM RATINGS (T _A = 25°C unless otherwise noted)			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±25	V
Drain Current-Continuous @ T _J = 25°C	I _D	8	A
-Pulsed ^b	I _{DM}	35	A
Drain-Source Diode Forward Current ^a	I _S	1.7	A
Maximum Power Dissipation ^a	P _D	1.5	W
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C
THERMAL CHARACTERISTICS			
Thermal Resistance, Junction-to-Ambient ^a	R _{θJA}	82	°C/W

South Sea Semiconductor reserves the right to make changes to improve reliability or manufacturability without advance notice.

South Sea Semiconductor, February 2008 (Rev 1.0)



N-Channel Electrical Characteristics (TA = 25°C unless otherwise noted)						
Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250 μA	30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =24V, V _{GS} =0V			1	μA
Gate-Body Leakage	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} I _D =250 μA	1	1.6	2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =7A			23	mΩ
		V _{GS} =4.5V, I _D =5A			43	
On-State Drain Current	I _{D(ON)}	V _{DS} =5V, V _{GS} =10V	25			A
Forward Transconductance	g _{FS}	V _{DS} =5V, I _D =6A		15		S
Input Capacitance	C _{ISS}	V _{DS} =15V		760		pF
Output Capacitance	C _{OSS}	V _{GS} =0V		130		
Reverse Transfer Capacitance	C _{RSS}	f=1.0MHz		100		
Turn-On Delay Time	t _{D(ON)}	V _{DD} =10V, I _D =1A, V _{GEN} =10V, R _{GEN} =6Ω, R _L =15Ω		16		ns
Rise Time	t _r			7		
Turn-Off Delay Time	t _{D(OFF)}			22		
Fall Time	t _f			10		
Total Gate Charge	Q _g	V _{DS} =15V, I _D =2A, V _{GS} =10V		15		nC
		V _{DS} =15V, I _D =2A, V _{GS} =4.5V		7		
Gate-Source Charge	Q _{gs}	V _{DS} =15V, I _D =2A, V _{GS} =4.5V		2		
Gate-Drain Charge	Q _{gd}			3		
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _D =1.5A		0.8	1.2	V

Notes :

- a. Surface Mounted on FR4 Board, t ≤ 10 sec.
- b. Pulse Test : Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
- c. Guaranteed by design, not subject to production testing.

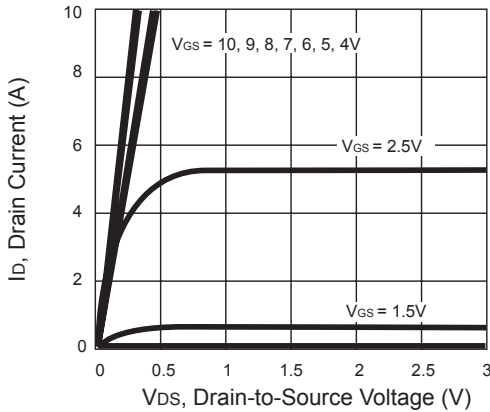


Figure 1. Output Characteristics

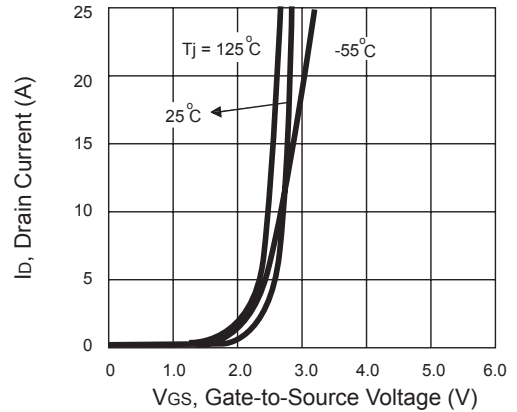


Figure 2. Transfer Characteristics

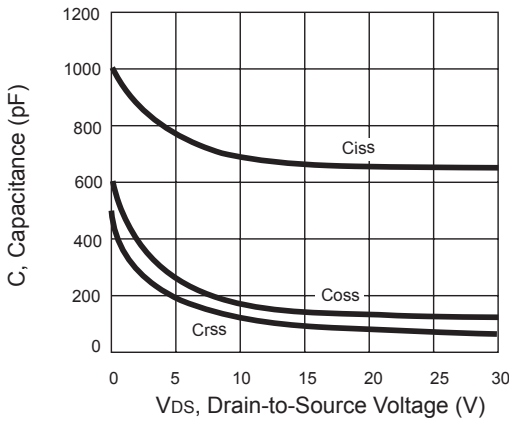


Figure 3. Capacitance

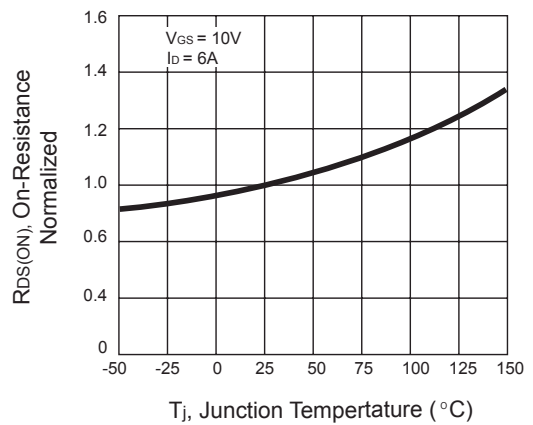


Figure 4. On-Resistance Variation with Temperature

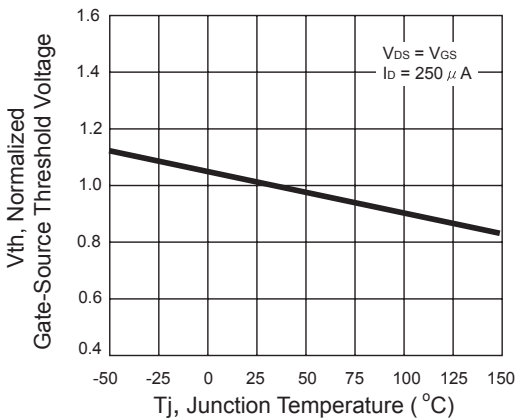


Figure 5. Gate Threshold Variation with Temperature

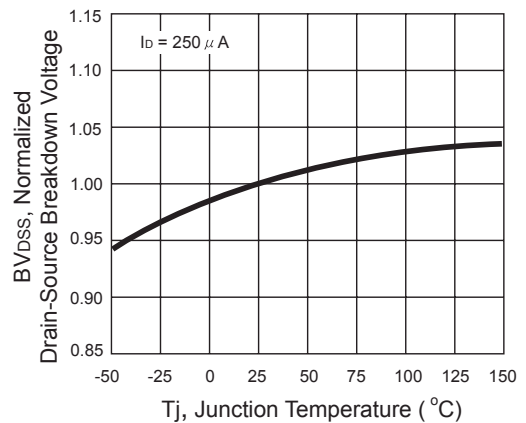


Figure 6. Breakdown Voltage Variation with Temperature

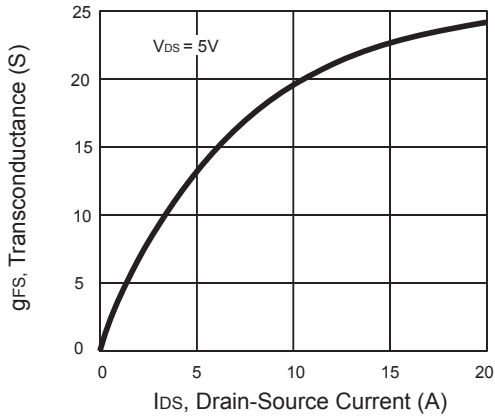


Figure 7. Transconductance Variation with Drain Current

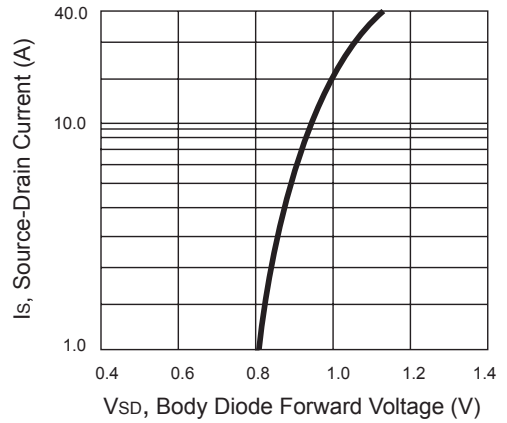


Figure 8. Body Diode Forward Voltage Variation with Source Current

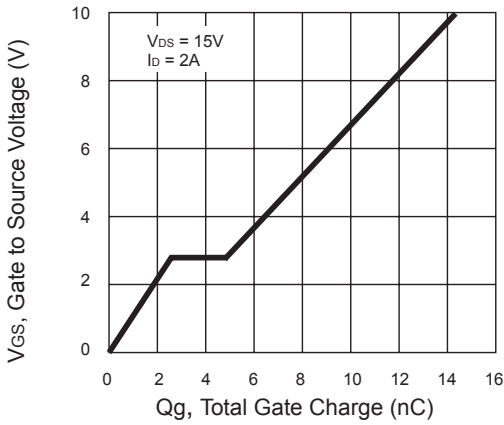


Figure 9. Gate Charge

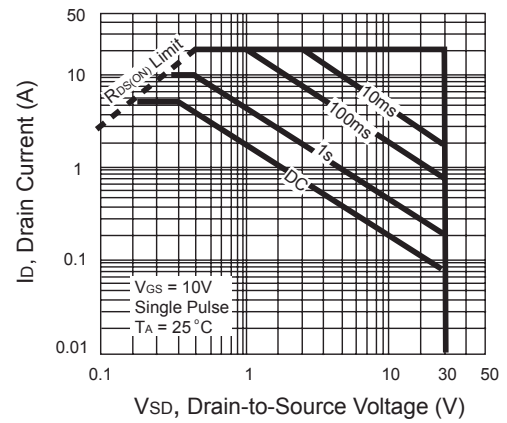


Figure 10. Maximum Safe Operating Area

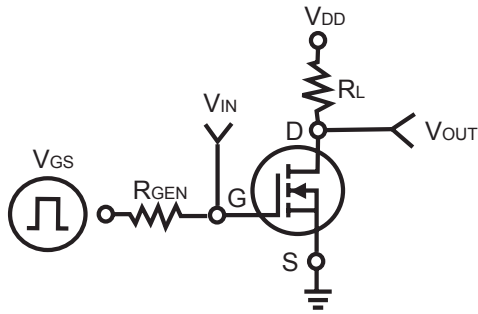


Figure 11. Switching Test Circuit

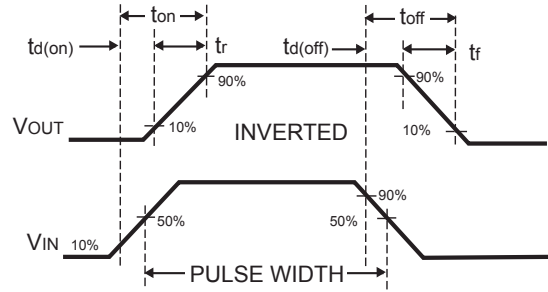


Figure 12. Switching Waveforms

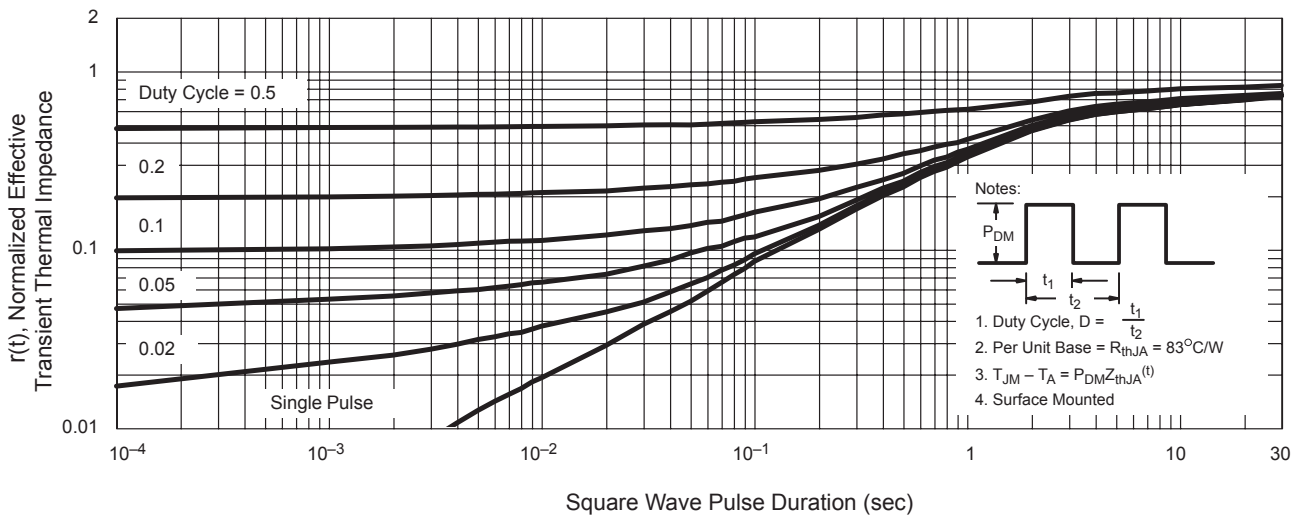


Figure 13. Normalized Thermal Transient Impedance Curve